www.DataSheet4U-f69SHIBA BI-DIRECTIONAL TRIODE THYRISTOR SILICON PLANAR TYPE

# **SM3GZ47,SM3JZ47**

## AC POWER CONTROL APPLICATIONS

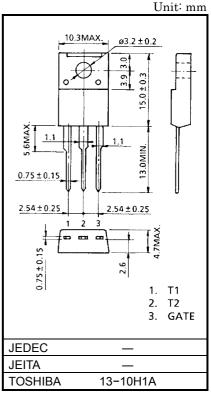
Repetitive Peak Off-State Voltage : V<sub>DRM</sub> = 400, 600V
 R.M.S ON-State Current : I<sub>T</sub> (RMS) = 3A

• High Commutating (dv / dt)

• Isolation Voltage : V<sub>ISOL</sub> = 1500V AC

### **MAXIMUM RATINGS**

CHARACTERIS	SYMBOL	RATING	UNIT		
Repetitive Peak	SM3GZ47	$V_{DRM}$	400	V	
Off-State Voltage	SM3JZ47	V DRM	600	V	
R.M.S On-State Current (Full Sine Waveform Tc = 110°C)		I <sub>T (RMS)</sub>	3	Α	
Peak One Cycle Surge On-State Current (Non-Repetitive)		l=a	30 (50Hz)	А	
		ITSM	33 (60Hz)		
I <sup>2</sup> t Limit Value (t = 1~10n	ı²t	4.5	A <sup>2</sup> s		
Critical Rate of Rise of O Current	di / dt	50	A / μs		
Peak Gate Power Dissipation		$P_{GM}$	5	W	
Average Gate Power Dissipation		P <sub>G (AV)</sub>	0.5	W	
Peak Gate Voltage		$V_{GM}$	10	V	
Peak Gate Current		I <sub>GM</sub>	2	Α	
Junction Temperature		Tj	-40~125	°C	
Storage Temperature Ra	T <sub>stg</sub>	-40~125	°C		
Isolation Voltage (AC, t =	V <sub>ISOL</sub>	1500	V		



Weight: 1.7g

Note 1: di / dt test condition  $V_{DRM} = 0.5 \times Rated$   $I_{TM} \le 4.5 A$   $t_{gw} \ge 10 \mu s$   $t_{gr} \le 250 ns$ 

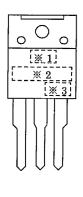
 $i_{gp} = I_{GT} \times 2.0$ 



## www.DataShact411.com CHARACTERISTICS (Ta = 25°C)

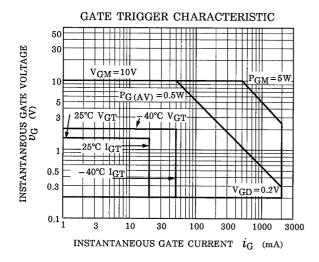
CHARACTERISTIC		SYMBOL	TEST CONDITION		MIN	TYP.	MAX	UNIT
Repetitive Peak Off-State Current		I <sub>DRM</sub>	V <sub>DRM</sub> = Rated		_	_	20	μA
Gate Trigger Voltage	I	V <sub>GT</sub>	V <sub>D</sub> = 12V R <sub>L</sub> = 20Ω	T2 (+), Gate (+)	_	_	1.5	V
	Ш			T2 (+), Gate (-)	_	_	1.5	
	III			T2 (-), Gate (-)	_	_	1.5	
	IV			T2 (-), Gate (+)	_	_	_	
Gate Trigger Current	I	I <sub>GT</sub>	V <sub>D</sub> = 12V R <sub>L</sub> = 20Ω	T2 (+), Gate (+)	_	_	20	- mA
	II			T2 (+), Gate (-)	_	_	20	
	III			T2 (-), Gate (-)	_	_	20	
	IV			T2 (-), Gate (+)	-	_	_	
Peak On-State Voltage		$V_{TM}$	I <sub>TM</sub> = 4.5A		-	_	1.5	V
Gate Non-Trigger Voltage		$V_{GD}$	V <sub>D</sub> = Rated, Tc = 125°C		0.2	_	_	V
Holding Current	olding Current $I_H$ $V_D = 12V$ , $I_{TM} = 1A$		-	_	30	mA		
Thermal Resistance	al Resistance R <sub>th (j-c)</sub> Junction to Case, AC		-	_	4.2	°C/W		
Critical Rate of Rise of Off-State Voltage		dv / dt	V <sub>DRM</sub> = Rated, T <sub>j</sub> = 125°C Exponential Rise		_	300	_	V / µs
Critical Rate of Rise of Off-State Voltage at Commutation		(dv / dt) c	$V_{DRM} = 400V$ , $T_j = 125^{\circ}C$ (di /dt) $c = -2.0A$ / ms		10	_	_	V/µs

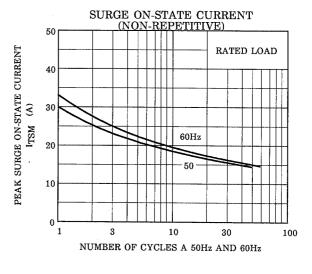
## **MARKING**

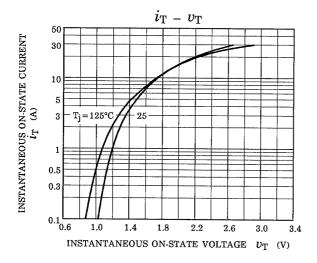


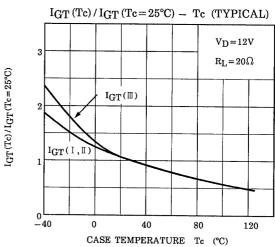
NUMBER		MARK		
* 1	TOSHIBA PRODUC	7		
* 2	TYPE	SM3GZ47	M3GZ47	
		SM3JZ47	M3JZ47	
* 3		(Starting from Alphabet A) (Last Decimal Digit of the Current Year	Example 8A : January 1998 8B : Febrary 1998 8L : December 1998	

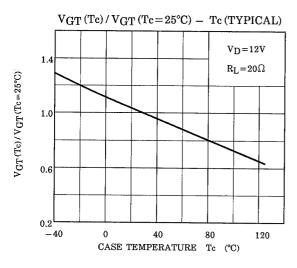
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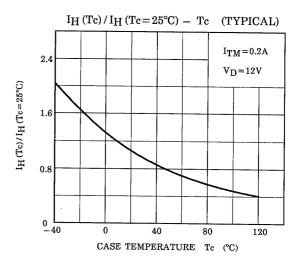




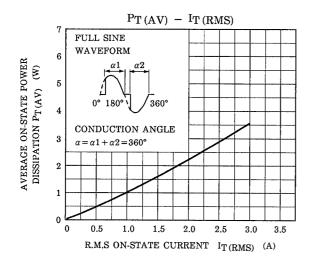


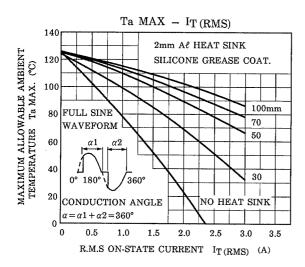


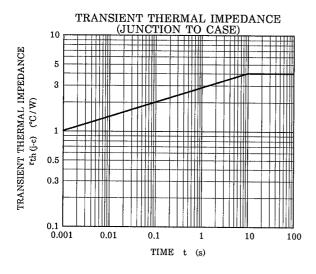


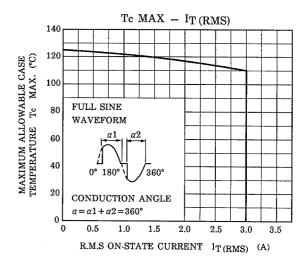


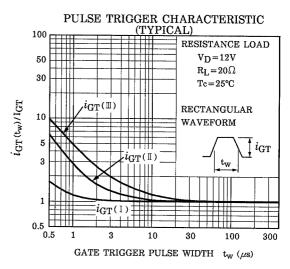
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